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| APPLICATION NO. | | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. |
|------------------------|-------|--------------|----------------------|-------------------------|------------------|
| 10/771,628 | | 02/03/2004 | M. Brandon Steele | 023228-0109 9539 | |
| 27433 | 7590 | 09/16/2005 | | EXAMINER | |
| FOLEY & | LARDN | IER | WALLING, MEAGAN S | | |
| 321 NORTI SUITE 280 | | STREET | | ART UNIT . | PAPER NUMBER |
| | - | L 60610-4764 | | | |
| | | | | DATE MAILED: 09/16/2003 | 5 |

Please find below and/or attached an Office communication concerning this application or proceeding.

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| | Application No. | Applicant(s) | Vi |
| | 10/771,628 | STEELE ET AL. | |
| Office Action Summary | Examiner | Art Unit | |
| | Meagan S. Walling | 2863 | |
| The MAILING DATE of this communication app Period for Reply | ears on the cover sheet with the c | orrespondence address | |
| A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). | ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE | J. nely filed the mailing date of this communicatio D (35 U.S.C. § 133). | |
| Status | | | |
| 1) ☐ Responsive to communication(s) filed on <u>03 Fe</u> 2a) ☐ This action is FINAL . 2b) ☐ This 3) ☐ Since this application is in condition for allowar closed in accordance with the practice under E | action is non-final. nce except for formal matters, pro | | s · |
| Disposition of Claims | | | |
| 4) ☐ Claim(s) 1-44 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw 5) ☐ Claim(s) 1-31 and 36-44 is/are allowed. 6) ☐ Claim(s) 32 and 35 is/are rejected. 7) ☐ Claim(s) 33 and 34 is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or | vn from consideration. | | |
| Application Papers | | | |
| 9) ☐ The specification is objected to by the Examine 10) ☑ The drawing(s) filed on 03 February 2004 is/are Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) ☐ The oath or declaration is objected to by the Ex | e: a)⊠ accepted or b)⊡ objecte drawing(s) be held in abeyance. See ion is required if the drawing(s) is ob | e 37 CFR 1.85(a). lected to. See 37 CFR 1.121(| d). |
| Priority under 35 U.S.C. § 119 | • | | |
| 12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the priority application from the International Bureau * See the attached detailed Office action for a list | s have been received. s have been received in Applicati ity documents have been receive ı (PCT Rule 17.2(a)). | on No ed in this National Stage | |
| Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 10/27/04, 1/27/05. | 4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other: | | |

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DETAILED ACTION

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 32 and 33 are rejected under 35 U.S.C. 102(b) as being anticipated by Knowles et 1. al. (US 5,546,477).

Regarding claim 32, Knowles et al. teaches decomposing the signal data into a wavelet domain (column 6, lines 16-19); obtaining a plurality of coefficients at a finite number of scales (column 11, lines 6-7); selecting for a peak signal (column 10, lines 3-6); and reconstructing the data by the coefficients in reverse order (column 13, lines 53-56).

Regarding claim 35, Knowles et al. teaches that the signal data is decomposed into the wavelet domain using a wavelet selected from the group consisting of "Coiflet", "Daubechies", and "Symmlet" (column 11, lines 1-3).

Allowable Subject Matter

Claims 33-34 are objected to as being dependent upon a rejected base claim, but would 2. be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The following is a statement of reasons for the indication of allowable subject matter:

The primary reason for the indication of allowability of claim 33 is the inclusion of the limitation that the peak signal is selected by selecting only wavelet coefficients at fine scales and by shrinking the fine scale coefficients based on a threshold. It is this limitation in the claimed combination that has not been found, taught, or suggested by the prior art that makes these claims allowable.

3. Claims 1-31 and 36-44 are allowed.

The following is an examiner's statement of reasons for allowance:

The primary reason for the allowance of claim 1 is the inclusion of the limitation of providing a wafer having a surface; providing a non-vibrating contact potential difference sensor; scanning the semiconductor wafer relative to the non-vibrating contact potential difference sensor; generating contact potential difference data from the non-vibrating contact potential difference sensor; and processing the non-vibrating contact potential difference sensor data to automatically detect a pattern that represents the defect. It is this limitation in the claimed combination that has not been found, taught, or suggested by the prior art that makes these claims allowable.

The primary reason for the allowance of claim 36 is the inclusion of the limitation of modeling the circuit as a first order RC circuit; converting the non-vibrating contact potential difference sensor signal into a discrete time transfer function; determining the impulse response of the discretized time transfer function; and deconvoluting each data track separately. It is this limitation in the claimed combination that has not been found, taught, or suggested by the prior art that makes these claims allowable.

The primary reason for the allowance of claim 37 is the inclusion of the limitation of a non-vibrating contact potential difference sensor; a height sensor; a device for moving the sensor relative to the semiconductor wafer; and a computer for receiving and analyzing wafer data generated by the sensor and processing the non-vibrating contact potential difference sensor data to automatically detect a pattern that represents a defects. It is this limitation in the claimed combination that has not been found, taught, or suggested by the prior art that makes these claims allowable.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Meagan S. Walling whose telephone number is (571) 272-2283. The examiner can normally be reached on Monday through Friday 8:30 AM to 5 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

msw

BRYAN BUI PRIMARY EXAMINER